Application/Control No. 10/601,576 Application/Control No. 10/601,576 Examiner Stephen J Stein Applicant(s)/Patent Under Reexamination MURAKAMI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,931,662 a	08-1999	Adachi et al.	432/6
	В	US-6,120,598 a	09-2000	lida et al.	117/13
	С	US-6,139,625 a	10-2000	Tamatsuka et al.	117/19
	D	US-6,413,310 b1	07-2002	Tamatsuka et al.	117/3
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	к	US-		,	
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200012786 A1	03-2000	World Intellect	AKIYAMA et al.	B32B 15/00
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	P					
(9)	Q					*
	R.					
	s					
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NON-PATENT DOCUMENTS

	TION-FAIENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
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	8					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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